

Table of Contents

Introduction

1.0 Foreword

2.0 About this document

3.0 Using this document

4.0 General Requirements

Parts Selection

Capacitors

Circuit Protection Devices

Fuses

Connectors

Filters

Inductors

Microcircuits

Monolithics

Hybrids

Resistors

Semiconductors (Summary)

Diodes

Transistors

Thermistors

Wire and Cable

Appendices

A - Derating Guidelines

B - Additional Parts Information Links

C - Prohibited Materials

1.0 FOREWORD

The NASA EEE Parts Selection List (NPSL) has been developed as a "parts selection tool" specifically geared toward design and parts engineering organizations internal to NASA and to universities and original equipment manufacturers (OEMs) that do not have the resources for a dedicated quality and reliability infrastructure in parts engineering. The NPSL is a listing of electrical, electronic, and electromechanical (EEE) part types and advanced packaging technologies such as Multi-Chip Modules (MCM) which are produced under various government and/or industry quality systems.

Since NASA's Standard EEE Parts List, MIL-STD-975, was cancelled without replacement on May 3, 1998, the NPSL provides a viable alternative for parts selection. However, there are some key differences in the philosophy of these two documents which users must be aware of:

MIL-STD-975 NPSL

Defines "Standard" and "Non-Standard" Parts Leaves standardization up to the individual flight projects Defines a "Non-Standard Parts Approval Request" (NSPAR) policy Leaves it to the individual flight projects to approve parts for the intended application Intended to be invoked as a contract requirement Not intended to be invoked as a contract requirement Very stringent requirements for parts listings Designed to facilitate listing of newer, advanced technologies

OEMs that have an established parts engineering infrastructure may elect to use the NPSL to augment their own existing part selection lists. The NPSL may be chosen, in part or in its entirety, to be a subset of a Project Approved Parts List (PAPL) or equivalent. The decision to invoke the NPSL shall be made by the project based on the parts management and control requirements for that mission. The NPSL itself, should not be imposed as a contractual requirement, but the associated part listings may be established as approved selections by the project.

2.0 ABOUT THIS DOCUMENT

2.1 General:

The NPSL is a selection tool providing designers with a list of EEE parts intended to meet system design requirements and NASA Parts Program quality/reliability levels. It is not mandatory that the parts listed herein be the only selections used to design a system, but if a particular function is needed and a suitable part is listed, the NASA EEE Parts Assurance Group (NEPAG) recommends the listed part as the first order of precedence for selection. Selecting a part from the NPSL may provide cost savings/ avoidance for the project because:

The procurement specification already exists The manufacturer has had a NASA survey or government audit performed The parts are available under one or several NASA accepted quality assurance systems Part qualification has been successfully completed All or most of the parts engineering has already been performed

The parts listed are approved for use only if NASA flight project approval is given. The document lists parts according to established quality assurance levels and NASA Parts Program knowledge of the product and manufacturer such as qualification history, GIDEP and failure trends, and delivery performance. This combination allows NEPAG to make a technical assessment of the quality, availability, capability and reliability and to list parts at a corresponding quality level within this document.

2.2 World Wide Web Access to the NPSL

The NPSL has been developed and will be maintained as an on-line World Wide Web homepage accessible via <http://nepp.nasa.gov/npsl>. The primary objectives of using the WWW as the platform for maintaining the NPSL are to:

Provide broad and ready access by NASA affiliated organizations world wide Facilitate quick updates, modifications, and revisions Provide links to additional EEE part information

Users will have to access the NPSL on-line and be able to download the document if a printout is desired.

2.3 Configuration Management

Under Construction

2.4 Appendices:

Appendix A (when released) will contain guidelines for derating parts. In general, these guidelines are accepted by NEPAG for use on all projects. Flight projects may elect to further develop these guidelines into requirements. Appendix A may not contain derating criteria for all part types, but guidelines provided can be used as a baseline for project derating requirements.

Appendix B is a repository of useful WWW links to additional parts information databases which can be accessed to support parts selection and application issues.

3.0 USING THIS DOCUMENT

The NPSL has been structured into four primary sections to facilitate finding the information of interest:

Welcome and User Feedback Section (Banner Page) Use Policy Section Parts Listings by Commodity Type Sections Appendices

The Parts Listings by Commodity Type Sections contains the actual part selection listings. The part types which will be covered in the NPSL consist of advanced packaging technologies such as MCMs and the commodities defined as electrical, electronic, and electromechanical (EEE) parts. The commodity types are listed below according to the Federal Stock Classification (FSC) system.

Part Types FSC

Capacitors 5910 Circuit Breakers 5925 Connectors 5935 Crystals and Crystal Oscillators 5955 Fiber Optics 60GP Filters 5915 Fuses 5920 Inductors 5950 Microcircuits (Monolithic and Hybrid) 5962 Relays 5945 Resistors 5905 Semiconductors (Diode and Transistor) 5961 Thermistors 5905 Transformers 5950 Wire and Cable 6145

Within each commodity class the parts are listed in order by procurement specifications in existence as NASA, DoD, or other space agency (e.g. ESA or NASDA) specifications. The part listing for each specification begins with a detailed explanation of the part numbering system. These explanations and the part listings which follow help the user "build" the appropriate part number for the project application. General functional descriptions and generic part number cross-references are provided to assist the user in matching functionality. The part quality levels, radiation tolerance levels (if known), and the available manufacturer sources are also identified.

Although extensive efforts have been made to maintain the accuracy of the supplier information within the part listings, users are encouraged to visit the Defense Supply Center Columbus (DSCC), <http://www.dsccl.dla.mil/programs/qmlqpl/>. DSCC is the Department of Defense agency responsible for certifying suppliers of military specification EEE parts. At this site, users can download the latest Qualified Products List (QPL) for the part type of interest.

4.0 GENERAL REQUIREMENTS

Selection of parts for inclusion in the device listings in this document is based on a review of technical data by the NASA EEE Parts Assurance Group (NEPAG) for quality and reliability trends. The major criteria used to evaluate candidate parts are:

- o Quality system and assurance level the products are produced under
- o Product performance
- o Product workmanship assessments
- o Destructive Physical Analysis results
- o Failure histories
- o Reliability trends
- o GIDEP alert histories of the product and manufacturer
- o Qualification and screening test results
- o Product availability
- o Manufacturer audit and survey results
- o Manufacturer responsiveness to corrective actions
- o Manufacturer delivery histories

Participation by the manufacturers in a quality program such as QPL, QML, and ISO 9000. will not automatically qualify their products for listing in the NPSL. Listings will be based on results from assessments of all the major criteria listed above. EEE parts-related activities throughout NASA provide recommendations for listing parts in this document.

NOTE: Unless specifically stated within the parts selection tables of the NPSL, listing of a device technology herein does NOT imply/guarantee Radiation Hardness Assurance (RHA). Applications concerned with a device's ability to tolerate exposure to various forms of space radiation (e.g., total ionizing dose, single event effects, etc.) should be reviewed and have the device assessed by the Program's radiation assurance experts. The following resources may also be consulted for initial guidance:

NASA Goddard Radiation Effects and Analysis Jet Propulsion Laboratory Radiation Effects

4.1 NASA Parts Levels

The NPSL lists products based on three quality levels defined by NEPAG: Level 1, Level 2, and Level 3. The definitions for each Level and the criteria used to list a part in a particular Level are not part approvals nor is this document a project approved parts list. The NPSL will not provide information on whether or not a part meets individual project flight requirements. Instead, it provides a list of products and associated manufacturers that meet recognized quality assurance baselines, qualification test regimens, and screening requirements necessary for space flight acceptance based on levels of risk. The part selected must be assessed independently by the project or the NASA center or OEM's parts organization to determine if it meets the requirements for the project. The parts engineering organizations at the NASA centers will assist users in making this determination. The Levels herein are not directly related to mission classification, cost, or schedule and users should make the appropriate Level tradeoffs when considering which parts to choose from the list.

4.1.1 Level 1:

Level 1 is the highest product assurance class assigned to parts listed in this document. Level 1 parts are those produced under assurance classes recognized by NASA as providing the highest possible level of quality and reliability (e.g. QML Class V K, JANS for discrete semiconductors, QPL Class S, Failure Rate Level (FRL) S), from NASA approved manufacturing sources, and meeting NASA space level parts and packaging program assessment criteria. The technical assessment results for Level 1 products will show that no known trends exist which have a negative impact on the quality, reliability, or performance for space flight applications. The Level 1 criteria is summarized as follows:

- o The supplier's facility(s) must be certified under a recognized quality assurance system (e.g. QML, QPL, ISO 9000) and produce products to the space industry recognized highest assurance classes (e.g. QML V, JANS for discrete semiconductors, QPL Class S, FRL S, GSFC S311 specification) or equivalent. There are exceptions to these levels where this preferred part reliability level is unavailable; these exceptions are shown in the individual part listings.
- o A Defense Supply Center Columbus (DSCC) audit or a NASA program manufacturer survey to the highest assurance classes must have been successfully completed within the past 2 years.
- o A part procurement specification, containing the highest assurance class requirements, must exist. Parts must have been procured previously by a NASA project using this specification.
- o Historical DPA and other parts analysis data on the manufacturer's products must be available and not reveal poor workmanship trends or rejection trends.
- o Failure analyses history for the manufacturers products should not reveal problem trends attributed to part quality and reliability.
- o No recent unresolved GIDEP Alerts (past 3 years) exist that have a major impact on the Level 1 products quality or reliability. No GIDEP Alert or NASA Parts Advisory trends exist on the manufacturer or product.
- o Available data on manufacturer performance must show no trend for late delivery of products to NASA projects.
- o Qualification to the requirements of the procurement specification must have been successfully completed. No qualification issues exist and no problem trends from previous qualifications exist.

4.1.2 Level 2:

Level 2 is the second highest product assurance class assigned to parts listed in this document. Level 2 parts are those produced under assurance classes recognized by NASA to have a high level of quality and reliability (e.g. QML Q H, QPL Class B, JANTXV for discrete semiconductors, FRL R or P), from NASA approved manufacturing sources, and meeting NASA space level parts and packaging program assessment criteria. The Level 2 criteria is summarized as follows:

- o The supplier's facility(s) must be certified under a recognized quality assurance system (e.g. QML, QPL, ISO 9000) and produce products to space industry recognized high assurance classes (e.g. QML Q, QPL B, JANTXV for discrete semiconductors, FRL R or P, GSFC S311 specification) or equivalent. Any exceptions to these levels where the preferred part reliability level is unavailable, are shown in the individual part listings.
- o A Defense Supply Center Columbus (DSCC) audit or a NASA program manufacturer survey must have been successfully completed within the past 2 years.
- o A part procurement specification, containing the high assurance class requirements, must exist. Parts must have been procured previously by a NASA project using this specification.
- o DPA and other parts analysis data on the manufacturer's products must be available and must not reveal any significant problems due to poor workmanship and must show minimal reject rates.
- o Failure analyses history for the manufacturers products should not reveal problem trends attributed to part quality and reliability.
- o No unresolved GIDEP Alert trends exist that have a major impact on the Level 2 products quality or reliability. No GIDEP Alert or NASA Parts Advisory trends exist on the manufacturer or product.
- o Available data on manufacturer performance must show consistent on-time delivery of products to NASA projects.
- o Qualification to the requirements of the procurement specification must have been successfully completed. Qualification issues and problems from previous qualifications must have been resolved (not by waiver).

4.1.3 Level 3:

Level 3 is the minimum product assurance class assigned to parts listed in this document. Level 3 contains many advanced electronic functions (from a space flight applications standpoint) and has been created to provide a technology insertion path into NASA flight projects. Parts listed are those produced by reputable manufacturers under a recognized quality assurance system (QML, QPL, ISO 9000) or their equivalent. Typically, only a limited amount of information is available to NEPAG for these parts and NASA has minimal visibility into the manufacturing and testing of Level 3 product. The parts are usually available commercially and have the capability to be used in space applications. The intent of Level 3 listings is to provide products that are newer, have greater functionality and enhanced performance characteristics, and provide higher levels of integration. Because the product has little or no

heritage in space flight application and data is unavailable or scarce, these parts are considered higher risk than the Level 1 and Level 2 parts. While the price of these parts may be less than the traditional Levels, more engineering evaluation may be needed to qualify the part for the project's application. The overall reliability and cost of ownership should be considered when selecting these parts. The Level 3 criteria is summarized as follows:

The manufacturer has supplied and qualified parts for several NASA space projects within the past 2 years. The parts and manufacturers have been recommended by one of the following NASA programs.

o PSAP o ASAP o ET o AIT

A NASA, DoD, or other space agency procurement specification (e.g. ESA SCC or NASDA QTS) exists. Available data on the manufacturer shows no significant problem trends such as GIDEP Alerts or NASA Parts Advisories, a low DPA rejection rate for the manufacturer's products in general, and no significant failures attributable to product quality and/or reliability.

NEPAG recommends selecting a Level 3 product when a higher Level part does not exist and/or enhanced functionality is required to meet system design requirements. Parts in this Level are not recommended for use in mission critical applications. Selecting these parts may require further engineering evaluation and approval by the project, but some heritage exists. Additionally, having more projects use these parts helps NEPAG acquire the technical data necessary for moving the parts into the higher Levels.

SECTION: THERMISTOR

Home

|

NASA Parts Selection List (NPSL)

| Thermistors

About NPSL

Prohibited Materials

Parts Selection Table of Contents

Capacitors

Circuit Protection Devices

Fuses

Connectors

Filters

Inductors

Microcircuits

NEW!

Monolithics

Hybrids

Resistors

Semiconductors

(Summary)

Diodes

Transistors

Thermistors

Wire and Cable

NASA Parts Selection List

Thermistors

The following Thermistor specifications are available for selection:

Military Specification	Generic Designator	Description
S-311-P-18	311P18	Thermistor, Negative Temperature Coefficient, Insulated and Uninsulated, Non-hermetic
MIL-T-23648	RTH	Thermistor, Insulated <!-- #EndEditable -->

Parts

|

Packaging

|

Radiation

|
Publications
|
Calendar
|
Experts
Admin Login
|
Request Account
|
Feedback
|
Site Map
|
Help
|
Search
NEPP Program Manager:
Chuck Barnes, Jet Propulsion Laboratory
Responsible NASA Official:
Michael Sampson, NEPAG Manager
Website Comments:
Web Development Team
Last Modified:

August 8, 2001
AETD IT Security Banner
NASA Privacy Statement
Go to -
NEPP
|
NPSL
|
Thermistors
MIL-PRF-23648, Thermistors
Thermistors, Insulated
RTH Styles
Part Number/Ordering Explanation
Important! Application Notes
Revision History for MIL-PRF-23648 Listing in the NPSL
Updated: 01/13/04

Click on the link below to see the associated parts selection listing:

Style	Detail Specification	Description
RTH42	MIL-PRF-23648/19	Thermistors, Positive Temperature Coefficient, Insulated

APPLICATION NOTES FOR MIL-PRF-23648

1) WARNING! Parts covered by this specification may contain internal connections that may reflow during installation. Heat sinking is recommended during mounting to prevent internal solder reflow.

Revision History for MIL-PRF-23648 Listing in the NPSL

01/13/04	Updated Mfr Listings to reflect latest QPL. RTI Electronics bought out the Ketema thermistor product lines circa 1999
05/11/99	Updated this section to show that the specification has been converted to a "performance" specification. Hence all references to the specification number have changed from MIL-T-23648 to MIL-PRF-23648
12/22/97	Initial Release of MIL-T-23648 Thermistor Section in the NPSL

Part Number Ordering Information, example and explanation:

RTH42ES102J where,

RTH	42	E	S	102	J
Style (Thermistor Conforming to MIL-PRF-23648)	Configuration	Resistance Ratio Characteristic	Lead Type	Zero Power Resistance @ 25deg.C	Zero Power Resistance Tolerance @ 25deg.C

[Click Here for Outline Dimensions](#)

Part number ordering options are developed using the following criteria:

Configuration	Specification		Resistance Ratio Characteristic	Value
42	MIL-PRF-23648/19		E	0.55 +/- 10%

				Characteristic J
Lead Type	Description		Temperature	Resistance Tolerance (+/-%)
			-55deg.C	20
S	Solderable		-15deg.C	13
			0deg.C	7
			+25deg.C	5
			+50deg.C	7
			+75deg.C	9
			+100deg.C	12
			+125deg.C	15

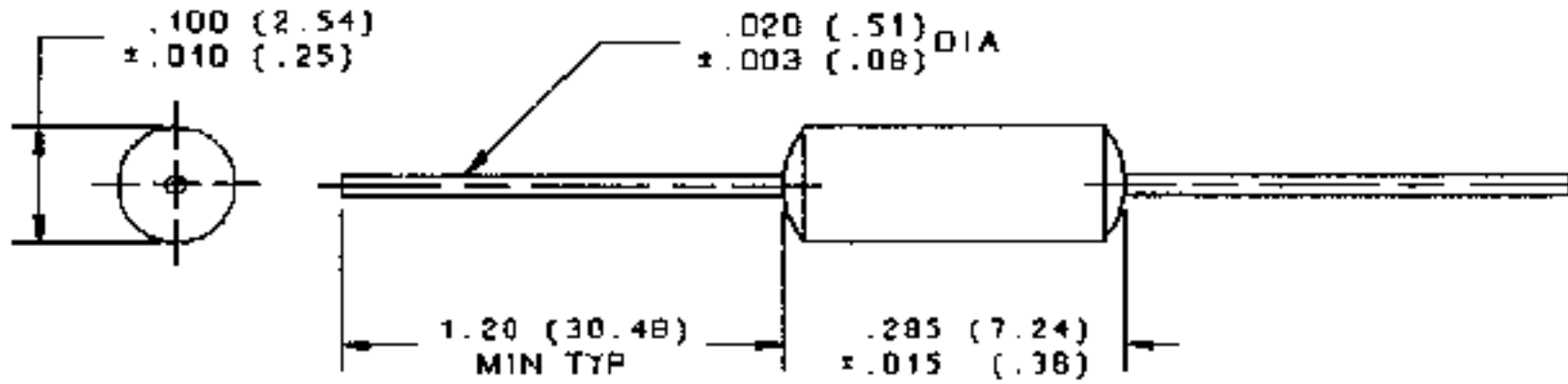
The zero power resistance @ 25deg.C is expressed in ohms and identified by a three digit number. The first two digits represent significant figures and the third digit represents the number of zeroes to follow.

Examples: 100 = 10 ohms

751 = 750 ohms

242 = 2400 ohms

RTH42 per MIL-PRF-23648/19



MIL-PRF-23648/19 (RTH42) Thermistors

[Click Here for Outline Dimensions](#)

Part Number	Zero Power Resistance @ 25deg.C (Ohms)	Zero Power Resistance Tolerance	Level	Manufacturer
RTH42ES100J	10	J	1 or 2	RTI, MSC, QTI
RTH42ES110J	11	J	1 or 2	RTI, MSC, QTI
RTH42ES120J	12	J	1 or 2	RTI, MSC, QTI
RTH42ES130J	13	J	1 or 2	RTI, MSC, QTI
RTH42ES150J	15	J	1 or 2	RTI, MSC, QTI
RTH42ES160J	16	J	1 or 2	RTI, MSC, QTI
RTH42ES180J	18	J	1 or 2	RTI, MSC, QTI
RTH42ES200J	20	J	1 or 2	RTI, MSC, QTI
RTH42ES220J	22	J	1 or 2	RTI, MSC, QTI
RTH42ES240J	24	J	1 or 2	RTI, MSC, QTI
RTH42ES270J	27	J	1 or 2	RTI, MSC, QTI

RTH42ES300J	30	J	1 or 2	RTI, MSC, QTI
RTH42ES330J	33	J	1 or 2	RTI, MSC, QTI
RTH42ES360J	36	J	1 or 2	RTI, MSC, QTI
RTH42ES390J	39	J	1 or 2	RTI, MSC, QTI
RTH42ES430J	43	J	1 or 2	RTI, MSC, QTI
RTH42ES470J	47	J	1 or 2	RTI, MSC, QTI
RTH42ES510J	51	J	1 or 2	RTI, MSC, QTI
RTH42ES560J	56	J	1 or 2	RTI, MSC, QTI
RTH42ES620J	62	J	1 or 2	RTI, MSC, QTI
RTH42ES680J	68	J	1 or 2	RTI, MSC, QTI
RTH42ES750J	75	J	1 or 2	RTI, MSC, QTI
RTH42ES820J	82	J	1 or 2	RTI, MSC, QTI
RTH42ES910J	91	J	1 or 2	RTI, MSC, QTI
RTH42ES101J	100	J	1 or 2	RTI, MSC, QTI
RTH42ES111J	110	J	1 or 2	RTI, MSC, QTI
RTH42ES121J	120	J	1 or 2	RTI, MSC, QTI
RTH42ES131J	130	J	1 or 2	RTI, MSC, QTI
RTH42ES151J	150	J	1 or 2	RTI, MSC, QTI
RTH42ES161J	160	J	1 or 2	RTI, MSC, QTI
RTH42ES181J	180	J	1 or 2	RTI, MSC, QTI
RTH42ES201J	200	J	1 or 2	RTI, MSC, QTI
RTH42ES221J	220	J	1 or 2	RTI, MSC, QTI
RTH42ES241J	240	J	1 or 2	RTI, MSC, QTI
RTH42ES271J	270	J	1 or 2	RTI, MSC, QTI
RTH42ES301J	300	J	1 or 2	RTI, MSC, QTI
RTH42ES331J	330	J	1 or 2	RTI, MSC, QTI
RTH42ES361J	360	J	1 or 2	RTI, MSC, QTI
RTH42ES391J	390	J	1 or 2	RTI, MSC, QTI
RTH42ES431J	430	J	1 or 2	RTI, MSC, QTI
RTH42ES471J	470	J	1 or 2	RTI, MSC, QTI
RTH42ES511J	510	J	1 or 2	RTI, MSC, QTI
RTH42ES561J	560	J	1 or 2	RTI, MSC, QTI
RTH42ES621J	620	J	1 or 2	RTI, MSC, QTI
RTH42ES681J	680	J	1 or 2	RTI, MSC, QTI
RTH42ES751J	750	J	1 or 2	RTI, MSC, QTI
RTH42ES821J	820	J	1 or 2	RTI, MSC, QTI
RTH42ES911J	910	J	1 or 2	RTI, MSC, QTI
RTH42ES102J	1,000	J	1 or 2	RTI, MSC, QTI
RTH42ES112J	1,100	J	1 or 2	RTI, MSC, QTI
RTH42ES122J	1,200	J	1 or 2	RTI, MSC, QTI
RTH42ES132J	1,300	J	1 or 2	RTI, MSC, QTI
RTH42ES152J	1,500	J	1 or 2	RTI, MSC, QTI
RTH42ES162J	1,600	J	1 or 2	RTI, MSC, QTI
RTH42ES182J	1,800	J	1 or 2	RTI, MSC, QTI
RTH42ES202J	2,000	J	1 or 2	RTI, MSC, QTI
RTH42ES222J	2,200	J	1 or 2	RTI, MSC, QTI
RTH42ES242J	2,400	J	1 or 2	RTI, MSC, QTI

RTH42ES272J	2,700	J	1 or 2	RTI, MSC, QTI
RTH42ES302J	3,000	J	1 or 2	RTI, QTI
RTH42ES332J	3,300	J	1 or 2	RTI, QTI
RTH42ES362J	3,600	J	1 or 2	RTI, QTI
RTH42ES392J	3,900	J	1 or 2	RTI, QTI
RTH42ES432J	4,300	J	1 or 2	RTI, QTI
RTH42ES472J	4,700	J	1 or 2	RTI, QTI
RTH42ES512J	5,100	J	1 or 2	RTI, QTI
RTH42ES562J	5,600	J	1 or 2	RTI, QTI
RTH42ES622J	6,200	J	1 or 2	RTI, QTI
RTH42ES682J	6,800	J	1 or 2	RTI, QTI
RTH42ES752J	7,500	J	1 or 2	RTI, QTI
RTH42ES822J	8,200	J	1 or 2	RTI, QTI
RTH42ES912J	9,100	J	1 or 2	RTI, QTI
RTH42ES103J	10,000	J	1 or 2	RTI, QTI

GSFC S-311-P-18 Thermistors

[Click Here for Outline Dimensions](#)

Part Number	Zero Power Resistance @ 25deg.C (Ohms)	Resistance Tolerance Limits 0deg.C to 70deg.C (+/-%)	Operating and Storage Temperature Range	Level	Manufacturer
311P18-01XXXX	2,252	1.02	-55deg.C to +90deg.C	1 or 2	YSI
311P18-02XXXX	2,252	0.51	-55deg.C to +70deg.C	1 or 2	YSI
311P18-03XXXX	3,000	1.02	-55deg.C to +90deg.C	1 or 2	YSI
311P18-04XXXX	3,000	0.56	-55deg.C to +70deg.C	1 or 2	YSI
311P18-05XXXX	5,000	1.02	-55deg.C to +90deg.C	1 or 2	YSI
311P18-06XXXX	5,000	0.51	-55deg.C to +70deg.C	1 or 2	YSI
311P18-07XXXX	10,000	0.93	-55deg.C to +90deg.C	1 or 2	YSI
311P18-08XXXX	10,000	0.56	-55deg.C to +70deg.C	1 or 2	YSI
311P18-09XXXX	30,000	1.00	-55deg.C to +90deg.C	1 or 2	YSI
311P18-10XXXX	30,000	0.50	-55deg.C to +70deg.C	1 or 2	YSI

Go to -

NEPP

|

NPSL

|

Thermistors

S-311-P-18, Thermistors

Thermistors, Negative Temperature Coefficient, Insulated and Uninsulated, Non-Hermetic

S-311-P-18 Styles

Part Number/Ordering Explanation

Important! Application Notes

Revision History for S-311-P-18 Listing in the NPSL

Initial Release: 12/22/97

Click on the link below to see the associated parts selection listing:

Style	Detail Specification	Description
311P18	GSFC S-311-P-18	Thermistors, Negative Temperature Coefficient, Insulated and Uninsulated, Non-hermetic Download NASA Goddard Specification

APPLICATION NOTES FOR S-311-P-18

1) WARNING! Use heat sinks when soldering or welding to thermistor leads.

2) For a thermistor suspended in still air, the thermal time constant is 10 seconds maximum, except lead style "E" which is 25 seconds maximum.

3) For a thermistor suspended in still air, the power dissipation constant is 1 mW/deg.C minimum. This constant does not apply to lead style "E".

Revision History for S-311-P-18 Listing in the NPSL

12/22/97	Initial Release of GSFC S-311-P-18 Thermistor Section in the NPSL
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Part Number Ordering Information, example and explanation:

311P18-01S7R6 where,

311P18	-01	S	7R6
GSFC Prefix (Thermistor, NTC Conforming to GSFC S-311-P-18)	Dash Number Corresponds to Zero Power Resistance @ 25deg.C	Lead Material	Lead Length in cm

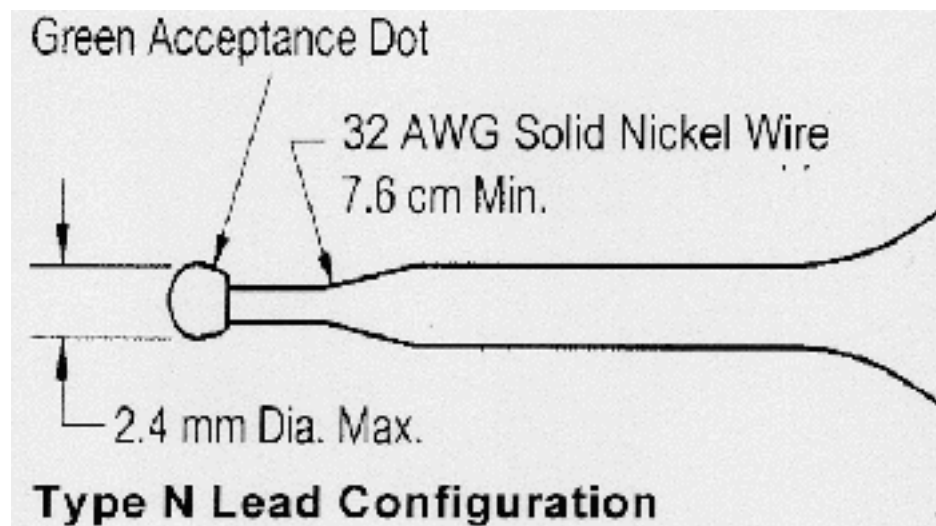
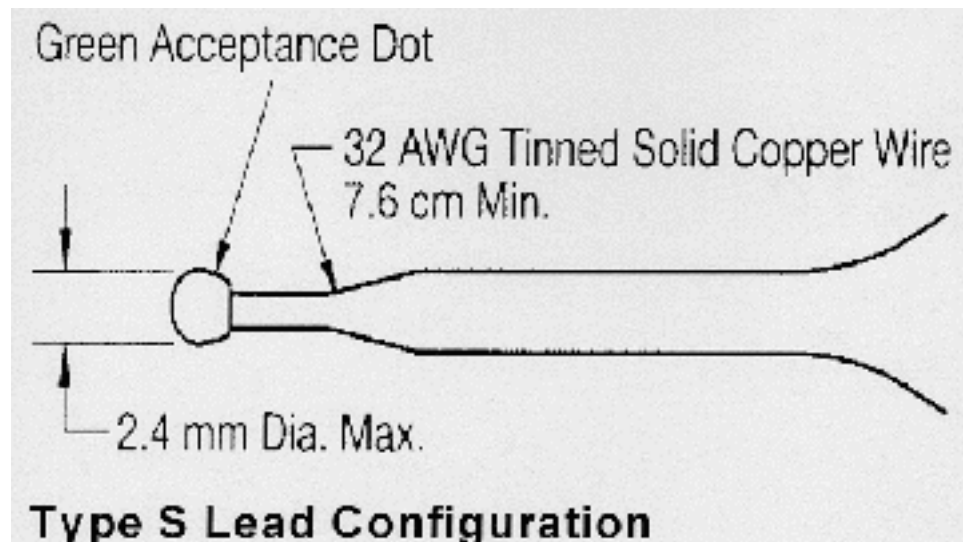
[Click Here for Outline Dimensions](#)

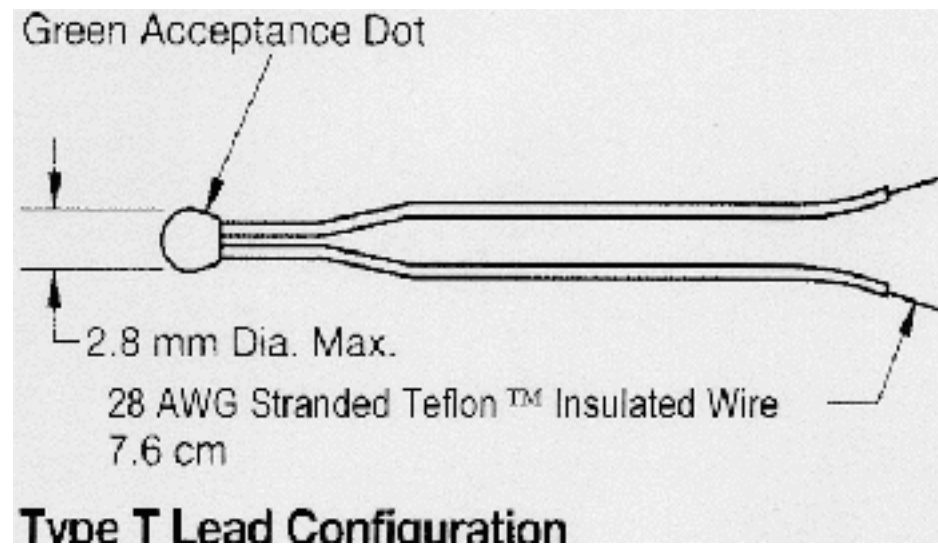
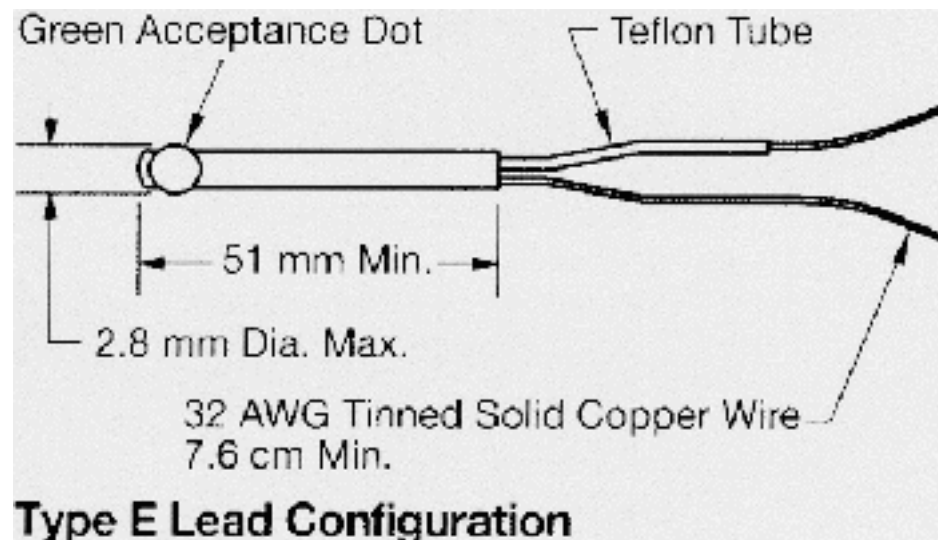
Part number ordering options are developed using the following criteria:

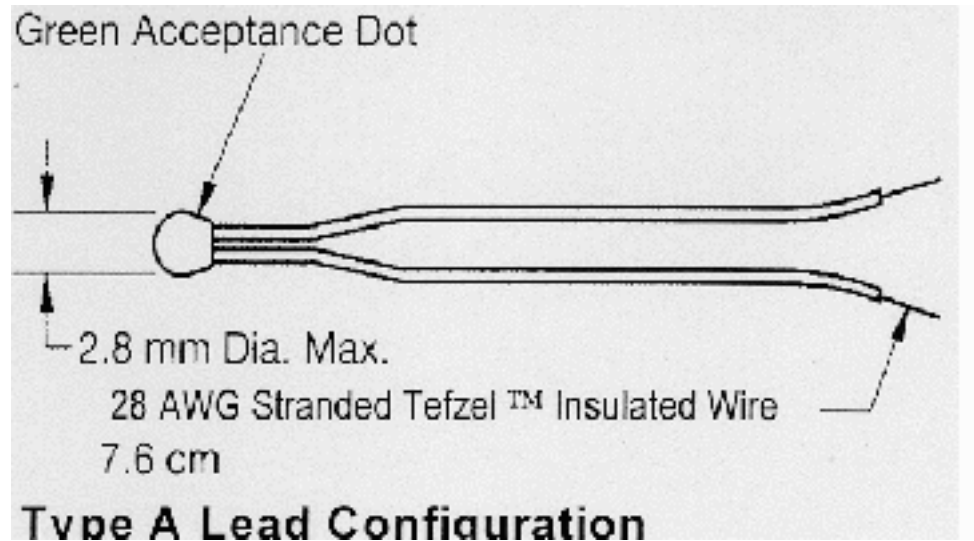
Lead Material	Description
S	32 AWG tinned solid copper wire, LW (0.20)C-51-N per MIL-STD-1276
N	32 AWG solid nickel wire, LW(0.20)N-01-N per MIL-STD-1276
E	32 AWG tinned solid copper wire, LW(0.20)C-51-N per MIL-STD-1276, one lead bare, one lead insulated with PTFE tubing per MIL-I-22129, covered with heat shrinkable FEP insulation per M23053/11-105
T	28 AWG silver coated stranded wire, PTFE per M16878/6BCB9
A	28 AWG silver coated stranded wire, ETFE per M22759/33-28-9

Standard lead lengths are from 7.6 cm to 100 cm. The lead length in centimeters (cm) is specified by three characters. For lengths from 7.6 cm to 9.9 cm, the letter "R" is used as the decimal point (e.g., 7R6 = 7.6 cm). For lengths from 10 cm to 99 cm, the letter "R" is used as the last character (e.g., 76R = 76 cm). For 100 cm lead length, the digits 101 are used. The first two digits represent significant figures and the last digit specifies the number of zeroes to follow.

S-311-P-18 Outline Dimensions







Thermistor Manufacturer Listing
And Links to Manufacturer Homepages

Click
here

for detailed information regarding part technologies offered by manufacturers listed in the
PSAP

Core Suppliers List

Listed below are links to manufacturer data sites that may provide additional part related information. The linked sites are not under the control of NPSL and NASA is not responsible for information contained in the linked site. We are providing these links for your convenience only.

RTI

RTI Electronics, Inc (Formerly - Ketema, Inc. Rodan Division)

1800 E. Via Burton

Anaheim, CA 92806

CAGE Code: 15454

Tel: 714-765-8200

MSC

Microsemi Corporation

580 Pleasant Street

Watertown, MA 02172

CAGE Code: 12969

QTI

Quality Thermistor, Inc.

2108 Century Way

Boise, ID 83709

CAGE Code: 56866

Tel: 208-377-3373

YSI

Yellow Springs, I

nc.

Rte. 68 P.O. Box 279

Yellow Springs, OH 45387

CAGE Code: 97794

Tel: 513-767-7241

Active Parts Core Suppliers List (CSL)

The Active Parts Core Suppliers Listing (CSL) is a listing of manufacturers who are considered preferred suppliers of monolithic microcircuits, hybrid microcircuits, transistors or diodes by NASA. The CSL consists of two parts:

Core Suppliers List Part I

Introduction Section I - Microcircuits Section II - Hybrids Section III - Diodes Section IV - Transistors

Core Suppliers List Part II

Japanese Space Agency (NASDA) Listings European Space Agency (ESA) Listings

NOTE: A Portable Document Format (PDF) reader will be needed to view the CSL files on this page. A PDF reader, along with installation instructions, can be obtained free from Adobe Systems Incorporated.

Part I follows, and includes only those suppliers who satisfy the following criteria:

Are listed in QML-38535 (Qualified Manufacturers List of Advanced Microcircuits Qualified Under Military Specification MIL-PRF-38535?), QML-38534 (?Qualified Manufacturers List of Custom Hybrid Microcircuits Qualified under Military Specification List of Custom Hybrid Microcircuits Qualified under Military Specification MIL-H-38534?) or QPL-19500 (?Qualified Products List of Products Qualified under Military Specification MIL-S-19500) Offer one or more products which are currently listed in either MIL-STD-975 or the GSFC PPL Offer QML/QPL products to quality assurance levels which are considered suitable for spaceflight use Have established a history of providing high reliability parts to NASA.

The CSL, Part II, includes active part suppliers, who are not necessarily QML/QPL-certified, but who satisfy the following criteria:

Manufacturers parts on DESC certified and qualified lines Have compiled a satisfactory history of supplying high reliability parts which are currently procured through contractor (or OEM) SCDs Manufacture parts to NASA specifications Are certified and qualified by ESA/NASDA to provide parts to ESA/SCC or NASDA specifications)

The CSL is intended to assist NASA project management, parts/reliability engineers and designers in avoiding EEE part reliability/mission schedule problems which can result when parts are procured from unproven suppliers or suppliers who show recent trends indicative of unsatisfactory performance.

For each manufacturer listed in the CSL, Part I, herein, there is accompanying information related to the processing technologies and product lines for which the manufacturer is considered a core supplier and the name/phone number of a company representative to whom questions may be directed.

The information described in this report was obtained from NASA GSFC Preferred Parts List (PPL-21), NASA Standard Electrical, Electronic and Electromechanical parts list (MIL-STD-975), Qualified Manufacturers List for Monolithic Microcircuits (QML-38535), Qualified Manufacturers list for Custom Hybrid Microcircuits (QML- 38534), and Qualified Products List for Diodes and Transistors (QPL-19500).

For convenience, the listings have been grouped by part commodity. Introductory remarks for each section provide an explanation of the information contained therein. Please note that the manufacturer's listing and the accompanying information are considered accurate at the time of issue of this document. However, the semiconductor industry is one known for rapid change of technology and development including fabrication processes and assembly locations. As a result, the listings are subject to change without notice; revisions or amendments will be issued, as necessary.

For additional information regarding this Core Suppliers Listing, please contact:

Ashok Sharma NASA Goddard Space Flight Center Greenbelt, Maryland 20771 Attn: Ashok Sharma (Active Parts Specialist Code 562) (301) 286-6165 (301) 286-1695 (fax)

Appendix B Additional Parts Information Links

Listed below are some useful Links to other data sites that can be used in obtaining additional part related information:

NASA Parts and Packaging Program (NPPP)

Site managed by the Jet Propulsion Laboratory (JPL) -- This Site Contains Electronic Parts Reliability Information Studies of Emerging Microelectronics Technologies Radiation Effects Information JPL's Electronic Parts Information Network System (EPINS)

Electronic Parts Information Management System (EPIMS) User ID/Password Controlled -- This Site Contains GIDEP Alerts GSFC Parts Analysis Web System (PAWS)
NASA Parts Advisories NASA Project Parts Lists Nonstandard Part Approval Requests Manufacturer CAGE code/address look up

GSFC SEU Radiation Data Bank

JPL's Radiation Data Bank

GSFC Procurement Specifications

Appendix C Prohibited Materials Section

The following section of the NASA Parts Selection List (NPSL) has been developed to identify materials often used in the manufacture and assembly of EEE parts that shall be prohibited from use in high reliability NASA electronic systems and flight hardware. Users are strongly urged to familiarize themselves with these issues to minimize the risk of introducing potential problems. In addition to the issues noted in this section, each commodity section within the NPSL has application notes that are unique to the commodity. Therefore, users should also review the application notes contained in each commodity section.

1. Pure Tin Plating 2. Cadmium Plating 3. Zinc Plating

Pure Tin Plating Prohibition

Policy:

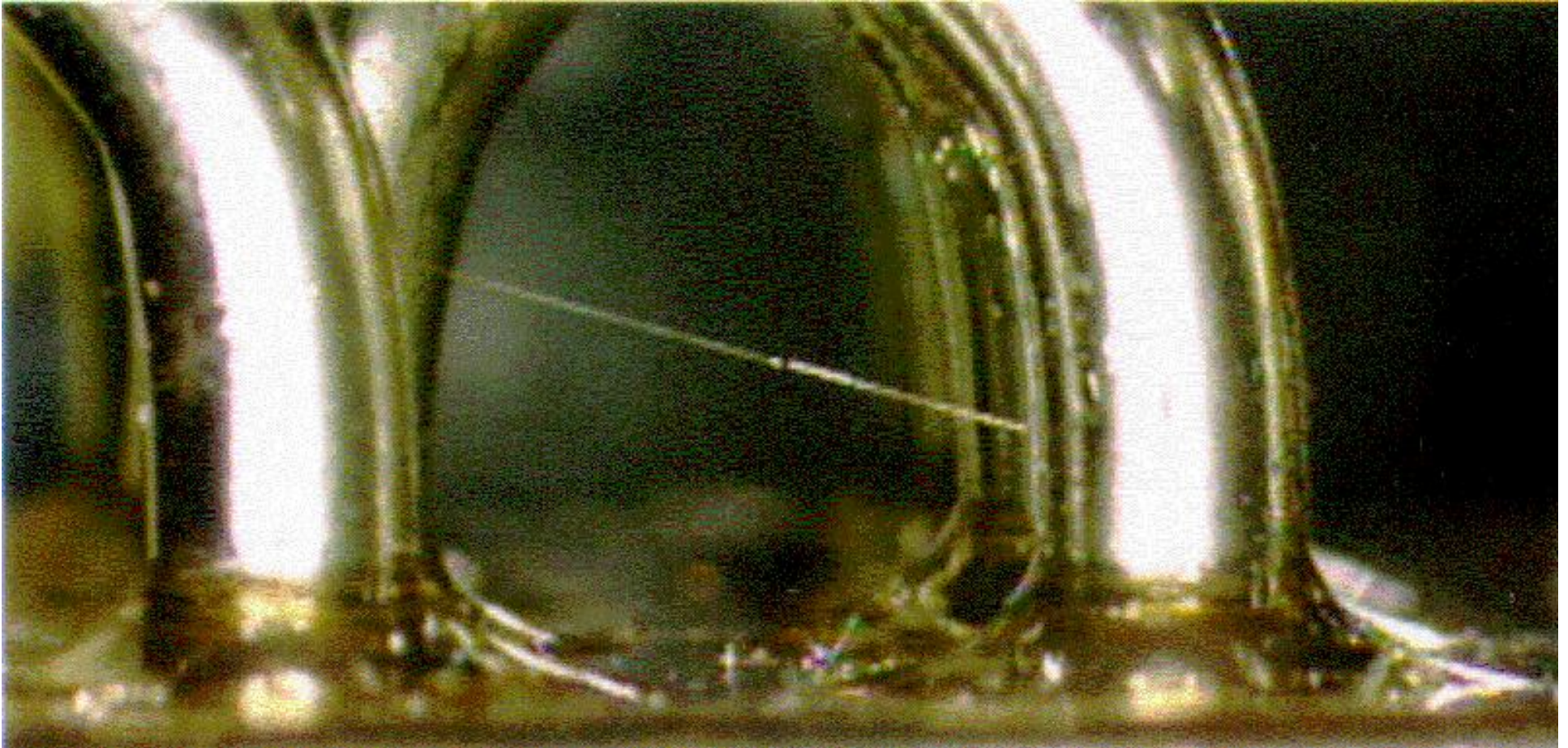
Pure tin plating is prohibited as a final finish on EEE parts and associated hardware

Reference:

NASA Advisory NA-044 October 23, 1998 NASA Advisory NA-044A December 17, 1998 NASA GSFC Tin Whisker Homepage

Rationale:

Pure tin finishes are susceptible to the spontaneous growth of electrically conductive single crystal structures known as tin whiskers. Over time these whiskers may grow to be several millimeters (mm) long. Tin whiskers are capable of causing electrical failures ranging from parametric deviations to sustained plasma arcing (in vacuum) that can result in catastrophic short circuits.



An Example of a Tin Whisker

Several instances have been reported where tin whiskers have caused system failures in both earth and space-based applications including at least 3 reports where a tin whisker induced short circuit resulted in complete failure of the commercial satellite.

The general risks fall into four categories:

Stable short circuits in low voltage, high impedance circuits. In such circuits there may be insufficient current available to fuse the whisker open and a stable short circuit results. Depending on the diameter and length of the whisker, it can take more than 50 milliamps (mA) to fuse one open. More typical is ~10mA. Transient short circuits. At atmospheric pressure, if the available current exceeds the fusing current of the whisker, the circuit may only experience a transient glitch as the whisker fuses open. Plasma arcing in vacuum. In vacuum a much more destructive phenomenon can occur. If currents of above a few amps are available, the whisker will fuse open but the vaporized tin may initiate a plasma that can conduct over 200 amps. An adequate supply of tin from the plated surface is necessary to sustain the arc. This phenomenon is reported to have occurred on several commercial satellites resulting in blown fuses that rendered the spacecraft non-operational. Debris/Contamination. Whiskers or parts of whiskers may break loose and bridge isolated conductors or interfere with optical surfaces.

Recommendations:

At this time, the only sure way of avoiding tin whiskers is not to use parts plated with pure tin. Despite procurement specification requirements that prohibit pure tin, errors sometimes occur resulting in pure tin plated components being delivered. Therefore, users are advised to independently test and analyze the plating composition of the products received as a verification that pure tin plating is not in use. Simple visual inspection is generally not sufficient because pure tin plating may appear similar to other plated finishes such as tin/lead or nickel.

Utilization of procurement specifications that have clear restrictions against the use of pure tin plating is still recommended. Most, but not all, of the commonly used military specifications currently have prohibitions against pure tin plating. Studies have shown that alloying tin with a second metal reduces the propensity for whisker growth. Alloys of tin and lead are acceptable where the alloy contains a minimum of 3% lead by weight.

In the event pure tin plated parts cannot be avoided, there are some additional processing techniques that may be used to reduce but not eliminate the risks associated with tin whiskers. The effectiveness of these approaches is variable and most require further evaluation to determine their suitability for long duration missions. Examples of these approaches include:

Solder dipping pure tin plated terminations and leads using a leaded solder. The effectiveness of this approach at covering all pure tin plated surfaces can be variable. Application of conformal coat material to pure tin plated surfaces. Conformal coat appears to reduce the growth rate of tin whiskers, but whiskers are still capable of growing through some conformal coat materials such as polyurethanes. For some device types manufacturers may be willing to replate surfaces using finishes such as tin/lead or nickel which are substantially less prone to whisker formation.

Cadmium Plating Prohibition

Policy:

Cadmium plating is prohibited on EEE parts and associated hardware. In some applications use of Cadmium plating may be acceptable via a Project approved waiver process that includes review and approval by both Materials and Parts Engineering disciplines.

Reference:

MSFC-HDBK-527, Materials Selection List for Space Hardware Systems JSC 11123, Space Transportation System Payload Safety Guidelines Handbook

Rationale:

There are several reasons for prohibiting the use of Cadmium plating in space flight electronic systems.

Cadmium is known to sublime in a hard vacuum environment (especially at temperatures above 75°C). The sublimation products, which are conductive, can redeposit resulting in short circuits. The sublimation products may also interfere with sensitive optics. Cadmium is a toxic material that should not be used in manned spaceflight applications. Cadmium is subject to the spontaneous growth of Cadmium whiskers. The propensity of Cadmium to grow whiskers

appears to be lower than that of zinc and especially tin. Cadmium whiskers (like tin whiskers) grow spontaneously and are capable of causing electrical failures ranging from parametric deviations to sustained plasma arcing that can result in catastrophic short circuits. See prohibition against pure tin plating for additional insight regarding the risks of metal whiskers.

Recommendations:

Cadmium plating is commonly used on connectors, connector hardware and mechanical hardware such as fasteners. It provides excellent resistance to salt corrosion and is therefore offered in many military specifications predominantly for use in naval applications. However, most NASA applications are not concerned with salt corrosion and the risks associated with use of Cadmium plating noted above outweigh the benefits of its use in spaceflight applications. There are several alternatives to Cadmium plating that are suited for spaceflight use. For connectors, electroless nickel plating is preferred. Gold plating is preferred when the application requires additional shielding effectiveness or low residual magnetism. Passivated stainless steel is the preferred material for hardware items such as fasteners. Consult your materials or parts specialists for suggested alternatives to Cadmium plating.

Zinc Plating Prohibition

Policy:

Zinc plating is prohibited on EEE parts and associated hardware. In some applications use of Zinc plating may be acceptable via a Project approved waiver process that includes review and approval by both Materials and Parts Engineering disciplines.

Reference: NA

Rationale:

There are several reasons for prohibiting the use of Zinc plating in space flight electronic systems.

Zinc is known to sublime in a vacuum environment (especially at elevated temperatures). The sublimation products are conductive and can result in short circuits. Zinc is subject to the spontaneous growth of Zinc whiskers. Zinc whiskers (like tin whiskers) grow spontaneously and are capable of causing electrical failures ranging from parametric deviations to sustained plasma arcing that can result in catastrophic short circuits. See prohibition against pure tin plating for additional insight regarding the risks of metal whiskers

Recommendations:

Zinc (galvanized) plating is occasionally used on mechanical hardware such as fasteners for its corrosion resistant properties. By using alternative plating materials most NASA applications can avoid the risks associated with the use of Zinc plating while still achieving suitable corrosion resistance. Consult your materials or parts specialists for suggested alternatives to Zinc plating.